

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/539,510	PIETIKAINEN ET AL.	
Examiner	Art Unit	
Eric Hua	1791	

SEARCHED				
Class	Subclass	Date	Examiner	
162	198 199 206 207	1/19/2008	EH	
162	252 253			
162	263 262			
162	289 290			
162	DIG.6			
162	DIG.10			
162	DIG.11			
700	127-129			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST- USPAT, USOCR, PGPUB, EPO, JPO, Derwent	1/19/2008	EH		
Assignee and inventor search				
D21F 7/00, 7/06, 5/00, 11/00 D21G 9/00				